

**RELIABILITY MONITOR REPORT
FOR**

0.35 μm Process

Dallas Semiconductor

**4401 South Beltwood Parkway
Dallas, TX 75244-3292**

**This Report was prepared by
Dallas Semiconductor Reliability Engineering**

Summary:

The data in the tables that follow was generated as the result of an on-going Process Reliability Monitor. The products covered by this process monitor are:

DS1088L	DS1099	DS2431	DS2460	DS2703
DS2780	DS2782	DS28E01	DS28E04	DS3984
DS3988	DS4026C	DS4303	DS4802	DS600
DS620	DSQ3301-K02			

The calculated failure rate for devices using this process is

The parameters used to calculate this failure rate are as follows:

Cf: 60% **Ea: 0.7** **B: 0** **Tu: 25 °C** **Vu: 5.5 Volts**

The reliability data follows. At the start of this data is the process information. The next section is the detailed reliability data for each stress. The reliability data section includes the latest data available. This report covers data between 04/01/2005 and 03/31/2006 .

Device Information:

Process: 0.35 µm Process
Interconnect: Aluminum / 1% Silicon / 0.5% Copper
Gate Oxide Thickness: 131 Å

OPERATING LIFE

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
HIGH TEMP OP LIFE	0508	DS2782	125C, 5.5 VOLTS	1000 HRS	77	0	
HIGH TEMP OP LIFE	0508	DS3988	125C, 5.5 VOLTS	1000 HRS	77	0	
HIGH TEMP OP LIFE	0513	DS4303	125C, 3.6 VOLTS	1000 HRS	72	0	
HIGH TEMP OP LIFE	0513	DS4026C	125C, 3.6 VOLTS	1000 HRS	45	0	
HIGH TEMP OP LIFE	0521	DS1099	125C, 5.5 VOLTS	1000 HRS	77	0	
LOW TEMP OP LIFE	0523	DS4303	25 C, 3.6 VOLTS	1000 HRS	72	0	
HIGH TEMP REVERSE BIAS	0527	DSQ3301-K02	125C, 5.5 VOLTS	1000 HRS	83	0	
Total:						0	

STORAGE LIFE

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
STORAGE LIFE	0513	DS4026C	150C	1000 HRS	77	0	
STORAGE LIFE	0523	DS4303	150C	1000 HRS	77	0	
STORAGE LIFE	0527	DSQ3301-K02	150C	1000 HRS	77	0	
Total:						0	

TEMPERATURE CYCLE

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
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TEMP CYCLE	0521	DS1099	-55C TO 125C	1000	CYS	77	0
TEMP CYCLE	0523	DS4303	-55C TO 125C	1000	CYS	77	0
TEMP CYCLE	0527	DSQ3301- K02	-55C TO 125C	100	CYS	77	
TEMP CYCLE	0527	DSQ3301- K02	-55C TO 125C	1000	CYS	77	0
Total:							0

TEMPERATURE HUMIDITY BIAS

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
HAST	0521	DS1099	130C, 85%R.H.,5.5V	96	HRS	77	0
HAST	0523	DS4303	130C, 85%R.H.,3.5V	100	HRS	76	0
BIASED MOISTURE	0527	DSQ3301- K02	85/85, 5.5 VOLTS	1000	HRS	82	0
Total:							0

UNBIASED MOISTURE RESISTANCE

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
AUTOCLAVE	0521	DS1099	121C, 2 ATM STEAM, UNBIASED	168	HRS	77	0
AUTOCLAVE	0523	DS4303	121C, 2 ATM STEAM, UNBIASED	168	HRS	71	0
MOISTURE SOAK	0527	DSQ3301- K02	85 C/85% R.H.	1000	HRS	77	0
Total:							0

W/E ENDURANCE AND DATA RET'N

DESCRIPTION	DATE CODE	TEST VEHICLE	CONDITION	READPOINT	QUANTITY	FAILS	FA NO
WRITE CYCLE STRESS (KCYS)	0508	DS2782	50 C, 5.5 VOLTS	50	KCYS	77	0
STORAGE LIFE			150C	1000	HRS	77	0
WRITE CYCLE STRESS (KCYS)	0508	DS3988	70 C, 5.5 VOLTS	30	KCYS	77	0
STORAGE LIFE			150C	1000	HRS	75	0
WRITE CYCLE STRESS (KCYS)	0513	DS4303	70 C, 3.6 VOLTS	30	KCYS	68	0
STORAGE LIFE			150C	1000	HRS	68	0
Total:							0